

# Search Notes



Application/Control No.

10/649,411

Examiner

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Applicant(s)/Patent under Reexamination

DRUMMER ET AL.

Art Unit

1765

## SEARCHED

Class	Subclass	Date	Examiner
438	692	6/2/2005	K-CC
	693		
	706		
	719		
438	725		
252	79.1		
252	79.5	6/2/05	K-CC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Keywords search USPAT, uspgt-pub. EPO, JPO, Derwent, IBM-TDB.	6/2/05	K-CC
inventor search	6/2/05	K-CC